

<b>Notice of References Cited</b>	Application/Control No. 10/585,612		Applicant(s)/Patent Under Reexamination MIYAHARA, SEIICHIRO	
	Examiner DANIELLE HENKEL		Art Unit 1797	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,626,236	09-2003	Bandoh et al.	165/206
*	B	US-5,802,856	09-1998	Schaper et al.	62/3.7
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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